

<b>Notice of References Cited</b>	Application/Control No. 10/823,575	Applicant(s)/Patent Under Reexamination EDAMURA ET AL.	
	Examiner Cuong Q. Nguyen	Art Unit 2811	Page 1 of 1

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	B	US-4,831,340	05-1989	Sollner, T. C. L. Gerhard	257/25
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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